

Search Notes

Application/Control No.

10/801,706

Examiner

Evan Dzierzynski

Applicant(s)/Patent under
Reexamination

PAN, WUN-FANG

Art Unit

2875

SEARCHED

Class	Subclass	Date	Examiner
362	654	6/21/2006	ED
	644	6/21/2006	ED
	652	6/21/2006	ED
	653	6/21/2006	ED

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search advice from Ali Alavi	6/21/2006	ED
EAST word search, attached	6/21/2006	ED